

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCX2573FT, TC74VCX2573FK

Low-Voltage Octal D-Type Latch with 3.6-V Tolerant Inputs and Outputs

The TC74VCX2573 is a high-performance CMOS octal D-type latch. Designed for use in 1.8, 2.5 or 3.3 Volt systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

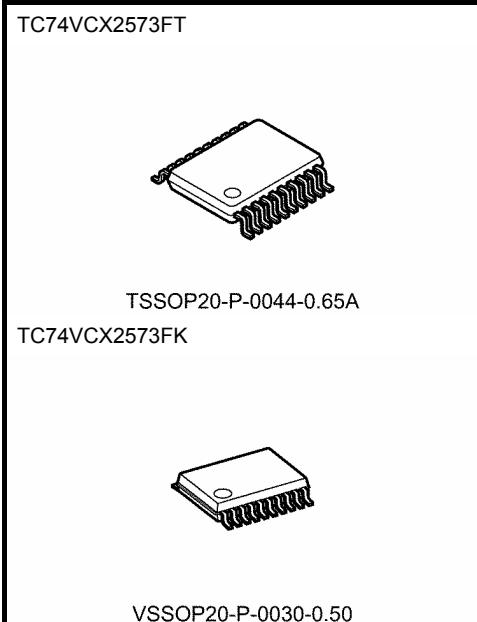
It is also designed with overvoltage tolerant inputs and outputs up to 3.6 V.

This 8 bit D-type latch is controlled by a latch enable input (LE) and an output enable input (\overline{OE}). When the \overline{OE} input is high, the eight outputs are in a high-impedance state. The $26\text{-}\Omega$ series resistor helps reducing output overshoot and undershoot without external resistor.

All inputs are equipped with protection circuits against static discharge.

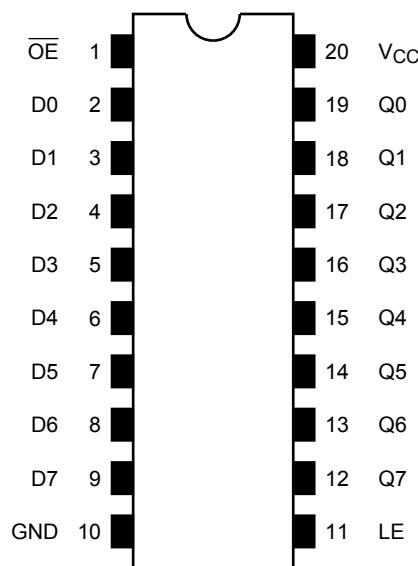
Features

- 26- Ω series resistors on outputs.
- Low-voltage operation: $V_{CC} = 1.8$ to 3.6 V
- High-speed operation: $t_{pd} = 5.1$ ns (max) ($V_{CC} = 3.0$ to 3.6 V)
 : $t_{pd} = 6.1$ ns (max) ($V_{CC} = 2.3$ to 2.7 V)
 : $t_{pd} = 9.8$ ns (max) ($V_{CC} = 1.8$ V)
- Output current: $I_{OH}/I_{OL} = \pm 12$ mA (min) ($V_{CC} = 3.0$ V)
 : $I_{OH}/I_{OL} = \pm 8$ mA (min) ($V_{CC} = 2.3$ V)
 : $I_{OH}/I_{OL} = \pm 4$ mA (min) ($V_{CC} = 1.8$ V)
- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200$ V
 Human body model $\geq \pm 2000$ V
- Package: TSSOP and VSSOP (US)
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs

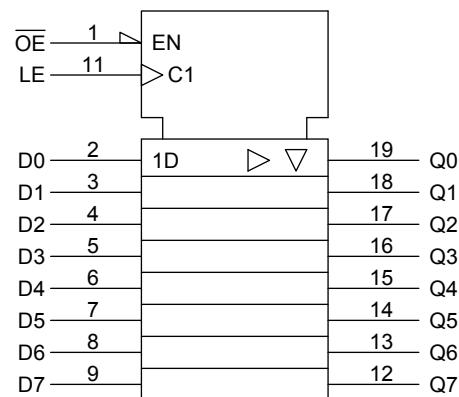


| Weight | |
|----------------------|-----------------|
| TSSOP20-P-0044-0.65A | : 0.08 g (typ.) |
| VSSOP20-P-0030-0.50 | : 0.03 g (typ.) |

Pin Assignment (top view)



IEC Logic Symbol



Truth Table

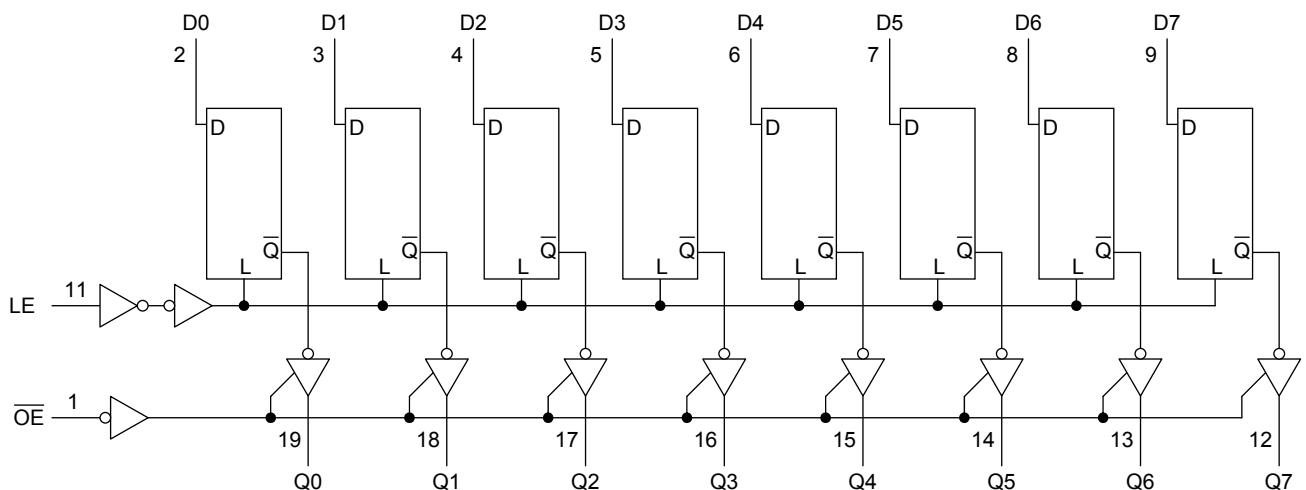
| Inputs | | | Outputs |
|-----------------|----|---|----------------|
| \overline{OE} | LE | D | |
| H | X | X | Z |
| L | L | X | Q _n |
| L | H | L | L |
| L | H | H | H |

X: Don't care

Z: High impedance

Q_n: Q outputs are latched at the time when the LE input is taken to a low logic level.

System Diagram



Absolute Maximum Ratings (Note 1)

| Characteristics | Symbol | Rating | Unit |
|------------------------------------|-----------------------------------|--|------|
| Power supply voltage | V _{CC} | -0.5 to 4.6 | V |
| DC input voltage | V _{IN} | -0.5 to 4.6 | V |
| DC output voltage | V _{OUT} | -0.5 to 4.6 (Note 2) | V |
| | | -0.5 to V _{CC} + 0.5 (Note 3) | |
| Input diode current | I _{IK} | -50 | mA |
| Output diode current | I _{OK} | ±50 (Note 4) | mA |
| DC output current | I _{OUT} | ±50 | mA |
| Power dissipation | P _D | 180 | mW |
| DC V _{CC} /ground current | I _{CC} /I _{GND} | ±100 | mA |
| Storage temperature | T _{stg} | -65 to 150 | °C |

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 2: OFF state

Note 3: High or low state. I_{OUT} absolute maximum rating must be observed.

Note 4: V_{OUT} < GND, V_{OUT} > V_{CC}

Operating Ranges (Note 1)

| Characteristics | Symbol | Rating | Unit |
|--------------------------|----------------------------------|-------------------------------|------|
| Power supply voltage | V _{CC} | 1.8 to 3.6 | V |
| | | 1.2 to 3.6 (Note 2) | |
| Input voltage | V _{IN} | -0.3 to 3.6 | V |
| Output voltage | V _{OUT} | 0 to 3.6 (Note 3) | V |
| | | 0 to V _{CC} (Note 4) | |
| Output current | I _{OH} /I _{OL} | ±12 (Note 5) | mA |
| | | ±8 (Note 6) | |
| | | ±4 (Note 7) | |
| Operating temperature | T _{opr} | -40 to 85 | °C |
| Input rise and fall time | dt/dv | 0 to 10 (Note 8) | ns/V |

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V_{CC} or GND.

Note 2: Data retention only

Note 3: OFF state

Note 4: High or low state

Note 5: V_{CC} = 3.0 to 3.6 V

Note 6: V_{CC} = 2.3 to 2.7 V

Note 7: V_{CC} = 1.8 V

Note 8: V_{IN} = 0.8 to 2.0 V, V_{CC} = 3.0 V

Electrical Characteristics**DC Characteristics (Ta = -40 to 85°C, 2.7 V < V_{CC} ≤ 3.6 V)**

| Characteristics | | Symbol | Test Condition | | V _{CC} (V) | Min | Max | Unit | |
|---------------------------------------|---------|------------------|---|---------------------------|---------------------|-----------------------|-------|------|--|
| Input voltage | H-level | | — | 2.7 to 3.6 | | | | | |
| | L-level | V _{IL} | — | 2.7 to 3.6 | — | 0.8 | — | V | |
| Output voltage | H-level | V _{OH} | V _{IN} = V _{IH} or V _{IL} | I _{OH} = -100 μA | 2.7 to 3.6 | V _{CC} - 0.2 | — | V | |
| | | | | I _{OH} = -6 mA | 2.7 | 2.2 | — | | |
| | | | | I _{OH} = -8 mA | 3.0 | 2.4 | — | | |
| | | | | I _{OH} = -12 mA | 3.0 | 2.2 | — | | |
| | L-level | V _{OL} | V _{IN} = V _{IH} or V _{IL} | I _{OL} = 100 μA | 2.7 to 3.6 | — | 0.2 | | |
| | | | | I _{OL} = 6 mA | 2.7 | — | 0.4 | | |
| | | | | I _{OL} = 8 mA | 3.0 | — | 0.55 | | |
| | | | | I _{OL} = 12 mA | 3.0 | — | 0.8 | | |
| Input leakage current | | I _{IN} | V _{IN} = 0 to 3.6 V | | 2.7 to 3.6 | — | ±5.0 | μA | |
| 3-state output OFF state current | | I _{OZ} | V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 3.6 V | | 2.7 to 3.6 | — | ±10.0 | μA | |
| Power-off leakage current | | I _{OFF} | V _{IN} , V _{OUT} = 0 to 3.6 V | | 0 | — | 10.0 | μA | |
| Quiescent supply current | | I _{CC} | V _{IN} = V _{CC} or GND V _{CC} ≤ (V _{IN} , V _{OUT}) ≤ 3.6 V | | 2.7 to 3.6 | — | 20.0 | μA | |
| Increase in I _{CC} per input | | ΔI _{CC} | V _{IH} = V _{CC} - 0.6 V | | 2.7 to 3.6 | — | 750 | | |

DC Characteristics (Ta = -40 to 85°C, 2.3 V ≤ V_{CC} ≤ 2.7 V)

| Characteristics | | Symbol | Test Condition | | V _{CC} (V) | Min | Max | Unit | |
|----------------------------------|---------|------------------|---|---------------------------|---------------------|-----------------------|-------|------|--|
| Input voltage | H-level | | — | 2.3 to 2.7 | | | | | |
| | L-level | V _{IL} | — | 2.3 to 2.7 | — | 0.7 | — | V | |
| Output voltage | H-level | V _{OH} | V _{IN} = V _{IH} or V _{IL} | I _{OH} = -100 μA | 2.3 to 2.7 | V _{CC} - 0.2 | — | V | |
| | | | | I _{OH} = -4 mA | 2.3 | 2.0 | — | | |
| | | | | I _{OH} = -6 mA | 2.3 | 1.8 | — | | |
| | | | | I _{OH} = -8 mA | 2.3 | 1.7 | — | | |
| | L-level | V _{OL} | V _{IN} = V _{IH} or V _{IL} | I _{OL} = 100 μA | 2.3 to 2.7 | — | 0.2 | | |
| | | | | I _{OL} = 6 mA | 2.3 | — | 0.4 | | |
| | | | | I _{OL} = 8 mA | 2.3 | — | 0.6 | | |
| | | | | I _{OL} = 12 mA | 2.3 to 2.7 | — | 0.8 | | |
| Input leakage current | | I _{IN} | V _{IN} = 0 to 3.6 V | | 2.3 to 2.7 | — | ±5.0 | μA | |
| 3-state output OFF state current | | I _{OZ} | V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 3.6 V | | 2.3 to 2.7 | — | ±10.0 | μA | |
| Power-off leakage current | | I _{OFF} | V _{IN} , V _{OUT} = 0 to 3.6 V | | 0 | — | 10.0 | μA | |
| Quiescent supply current | | I _{CC} | V _{IN} = V _{CC} or GND V _{CC} ≤ (V _{IN} , V _{OUT}) ≤ 3.6 V | | 2.3 to 2.7 | — | 20.0 | μA | |

DC Characteristics ($T_a = -40$ to 85°C , $1.8 \text{ V} \leq V_{CC} < 2.3 \text{ V}$)

| Characteristics | | Symbol | Test Condition | | $V_{CC} (\text{V})$ | Min | Max | Unit | |
|----------------------------------|---------|-----------|--|-----------------------------|---------------------|---------------------|---------------------|---------------|--|
| Input voltage | H-level | V_{IH} | — | | 1.8 to 2.3 | $0.7 \times V_{CC}$ | — | V | |
| | L-level | V_{IL} | — | | 1.8 to 2.3 | — | $0.2 \times V_{CC}$ | | |
| Output voltage | H-level | V_{OH} | $V_{IN} = V_{IH}$ or V_{IL} | $I_{OH} = -100 \mu\text{A}$ | 1.8 | $V_{CC} - 0.2$ | — | V | |
| | | | | $I_{OH} = -4 \text{ mA}$ | 1.8 | 1.4 | — | | |
| | L-level | V_{OL} | $V_{IN} = V_{IH}$ or V_{IL} | $I_{OL} = 100 \mu\text{A}$ | 1.8 | — | 0.2 | | |
| | | | | $I_{OL} = 4 \text{ mA}$ | 1.8 | — | 0.3 | | |
| Input leakage current | | I_{IN} | $V_{IN} = 0$ to 3.6 V | | 1.8 | — | ± 5.0 | μA | |
| 3-state output OFF state current | | I_{OZ} | $V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = 0$ to 3.6 V | | 1.8 | — | ± 10.0 | μA | |
| Power-off leakage current | | I_{OFF} | $V_{IN}, V_{OUT} = 0$ to 3.6 V | | 0 | — | 10.0 | μA | |
| Quiescent supply current | | I_{CC} | $V_{IN} = V_{CC}$ or GND $V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 \text{ V}$ | | 1.8 | — | 20.0 | μA | |
| | | | | | 1.8 | — | ± 20.0 | | |

AC Characteristics ($T_a = -40$ to 85°C , input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500 \Omega$) (Note 1)

| Characteristics | Symbol | Test Condition | V_{CC} (V) | Min | Max | Unit |
|----------------------------------|--------------------------|--------------------|---------------|-----|-----|------|
| | | | 1.8 | | | |
| Propagation delay time (D-Q) | t_{pLH} t_{pHL} | Figure 1, Figure 2 | 1.8 | 1.5 | 9.8 | ns |
| | | | 2.5 ± 0.2 | 0.8 | 6.1 | |
| | | | 3.3 ± 0.3 | 0.6 | 5.1 | |
| Propagation delay time (LE-Q) | t_{pLH} t_{pHL} | Figure 1, Figure 2 | 1.8 | 1.5 | 9.8 | ns |
| | | | 2.5 ± 0.2 | 0.8 | 6.3 | |
| | | | 3.3 ± 0.3 | 0.6 | 5.1 | |
| 3-state output enable time | t_{pZL} t_{pZH} | Figure 1, Figure 3 | 1.8 | 1.5 | 9.8 | ns |
| | | | 2.5 ± 0.2 | 0.8 | 6.5 | |
| | | | 3.3 ± 0.3 | 0.6 | 5.0 | |
| 3-state output disable time | t_{pLZ} t_{pHZ} | Figure 1, Figure 3 | 1.8 | 1.5 | 7.7 | ns |
| | | | 2.5 ± 0.2 | 0.8 | 4.3 | |
| | | | 3.3 ± 0.3 | 0.6 | 3.9 | |
| Minimum pulse width (LE) | t_w (H) | Figure 1, Figure 2 | 1.8 | 4.0 | — | ns |
| | | | 2.5 ± 0.2 | 1.5 | — | |
| | | | 3.3 ± 0.3 | 1.5 | — | |
| Minimum set-up time | t_s | Figure 1, Figure 2 | 1.8 | 2.5 | — | ns |
| | | | 2.5 ± 0.2 | 1.5 | — | |
| | | | 3.3 ± 0.3 | 1.5 | — | |
| Minimum hold time | t_h | Figure 1, Figure 2 | 1.8 | 1.0 | — | ns |
| | | | 2.5 ± 0.2 | 1.0 | — | |
| | | | 3.3 ± 0.3 | 1.0 | — | |
| Output to output skew | t_{osLH} t_{osHL} | (Note 2) | 1.8 | — | 0.5 | ns |
| | | | 2.5 ± 0.2 | — | 0.5 | |
| | | | 3.3 ± 0.3 | — | 0.5 | |

Note 1: For $C_L = 50$ pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

$$(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$$

Dynamic Switching Characteristics (Ta = 25°C, input: t_r = t_f = 2.0 ns, C_L = 30 pF)

| Characteristics | Symbol | Test Condition | V _{CC} (V) | Typ. | Unit |
|---|-------------------|--|---------------------|-------|------|
| | | | | | |
| Quiet output maximum dynamic V _{OOL} | V _{OOLP} | V _{IH} = 1.8 V, V _{IL} = 0 V (Note) | 1.8 | 0.15 | V |
| | | V _{IH} = 2.5 V, V _{IL} = 0 V (Note) | 2.5 | 0.25 | |
| | | V _{IH} = 3.3 V, V _{IL} = 0 V (Note) | 3.3 | 0.35 | |
| Quiet output minimum dynamic V _{OOL} | V _{OLV} | V _{IH} = 1.8 V, V _{IL} = 0 V (Note) | 1.8 | -0.15 | V |
| | | V _{IH} = 2.5 V, V _{IL} = 0 V (Note) | 2.5 | -0.25 | |
| | | V _{IH} = 3.3 V, V _{IL} = 0 V (Note) | 3.3 | -0.35 | |
| Quiet output minimum dynamic V _{OIH} | V _{OHV} | V _{IH} = 1.8 V, V _{IL} = 0 V (Note) | 1.8 | 1.55 | V |
| | | V _{IH} = 2.5 V, V _{IL} = 0 V (Note) | 2.5 | 2.05 | |
| | | V _{IH} = 3.3 V, V _{IL} = 0 V (Note) | 3.3 | 2.65 | |

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

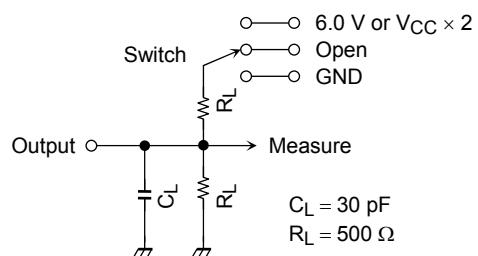
| Characteristics | Symbol | Test Condition | V _{CC} (V) | Typ. | Unit |
|-------------------------------|------------------|------------------------------------|---------------------|------|------|
| | | | | | |
| Input capacitance | C _{IN} | — | 1.8, 2.5, 3.3 | 6 | pF |
| Output capacitance | C _{OUT} | — | 1.8, 2.5, 3.3 | 7 | pF |
| Power dissipation capacitance | C _{PD} | f _{IN} = 10 MHz (Note) | 1.8, 2.5, 3.3 | 20 | pF |

Note: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

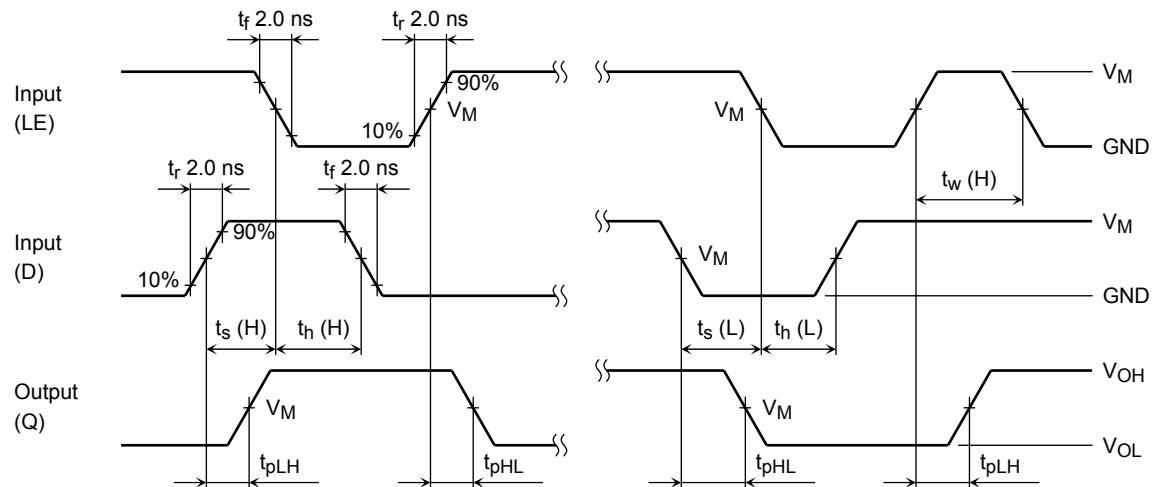
$$I_{CC} (\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$$

AC Test Circuit



| Parameter | Switch |
|--------------------|---|
| t_{pLH}, t_{pHL} | Open |
| t_{pLZ}, t_{pZL} | 6.0 V $V_{CC} \times 2$ $@V_{CC} = 3.3 \pm 0.3 \text{ V}$ $@V_{CC} = 2.5 \pm 0.2 \text{ V}$ $@V_{CC} = 1.8 \text{ V}$ |
| t_{pHZ}, t_{pZH} | GND |

Figure 1

Figure 2 $t_{pLH}, t_{pHL}, t_w, t_s, t_h$

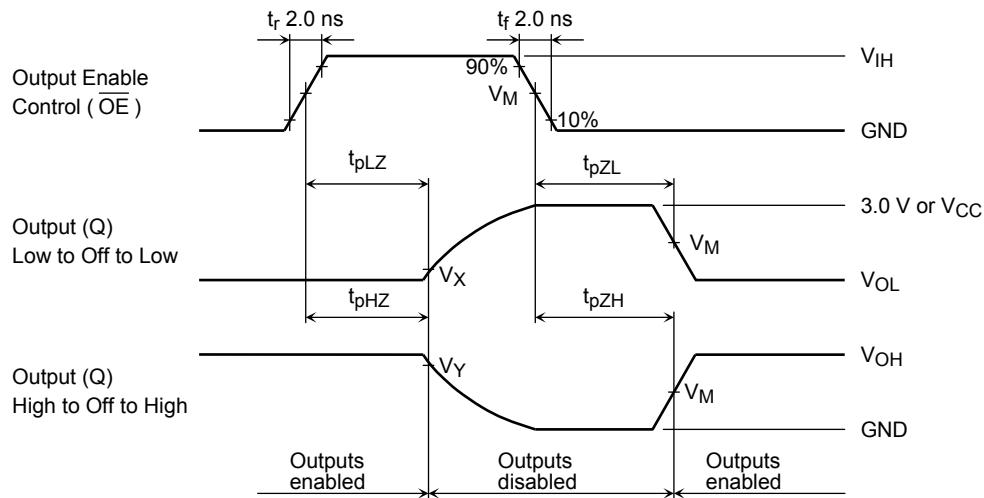


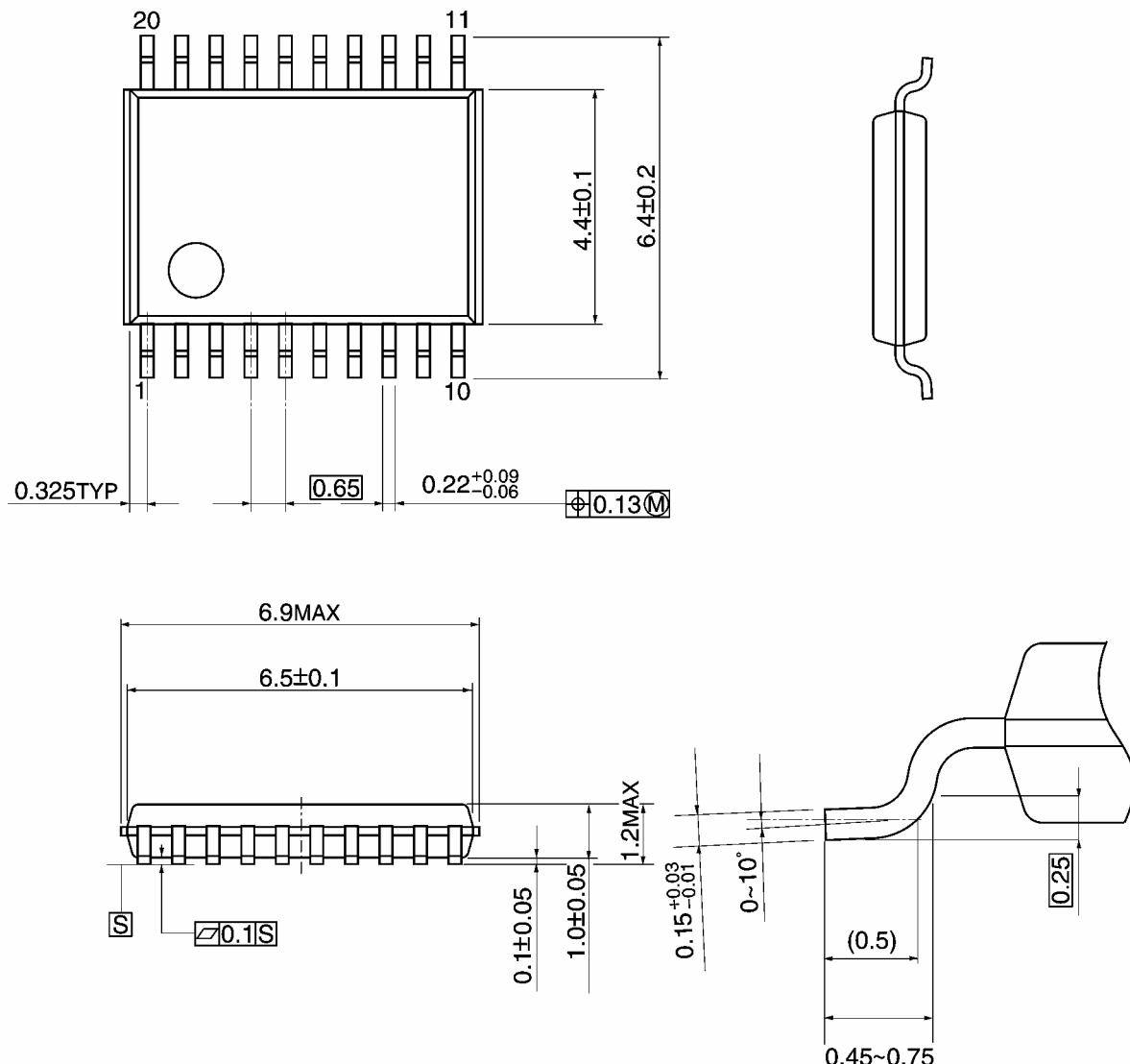
Figure 3 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

| Symbol | V_{CC} | | |
|----------|--------------------------|---------------------------|---------------------------|
| | $3.3 \pm 0.3 \text{ V}$ | $2.5 \pm 0.2 \text{ V}$ | 1.8 V |
| V_{IH} | 2.7 V | V_{CC} | V_{CC} |
| V_M | 1.5 V | $V_{CC}/2$ | $V_{CC}/2$ |
| V_X | $V_{OL} + 0.3 \text{ V}$ | $V_{OL} + 0.15 \text{ V}$ | $V_{OL} + 0.15 \text{ V}$ |
| V_Y | $V_{OH} - 0.3 \text{ V}$ | $V_{OH} - 0.15 \text{ V}$ | $V_{OH} - 0.15 \text{ V}$ |

Package Dimensions

TSSOP20-P-0044-0.65A

Unit: mm

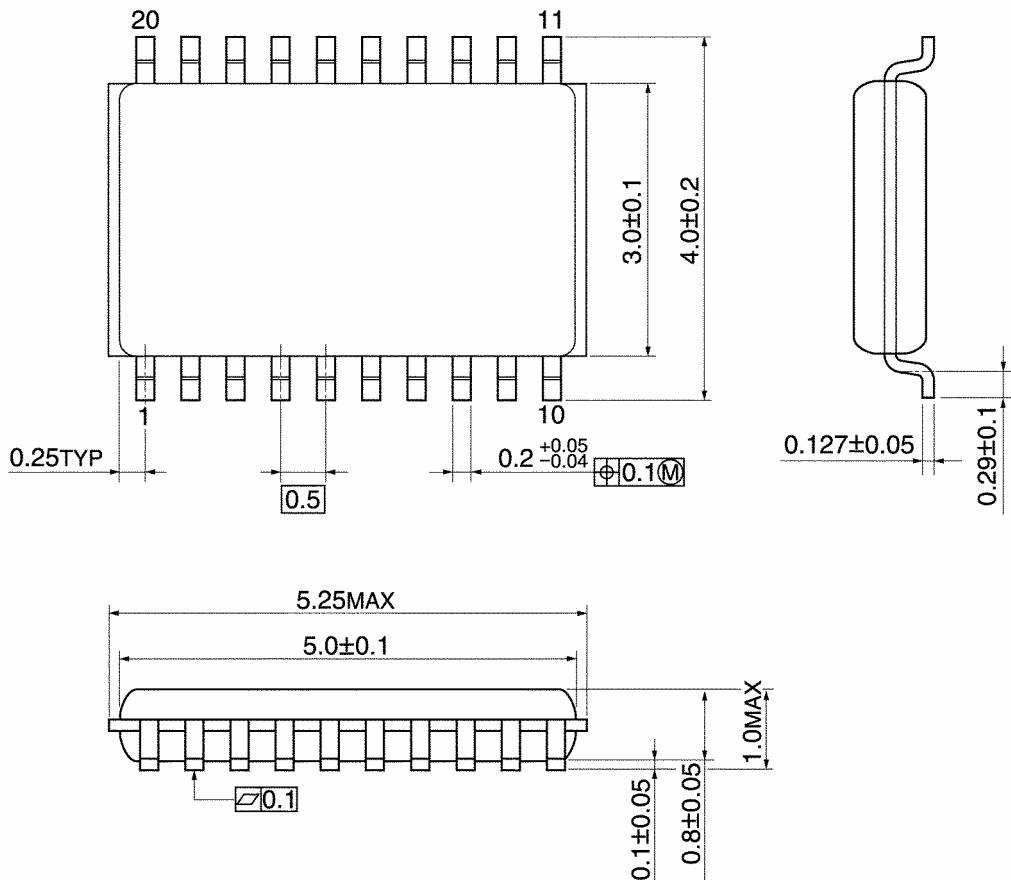


Weight: 0.08 g (typ.)

Package Dimensions

VSSOP20-P-0030-0.50

Unit: mm



Weight: 0.03 g (typ.)

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20070701-EN GENERAL

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